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HEXFET® TRANSISTORS IRFZ20 IRFZ22

N-Channel 50 Volt Power MOSFETs

50 Volt, 0.1 Ohm HEXFET
TO-220AB Plastic Package

Product Summary

Part Number	V_{DS}	$R_{DS(on)}$	I_D
IRFZ20	50V	0.10Ω	15A
IRFZ22	50V	0.12Ω	14A

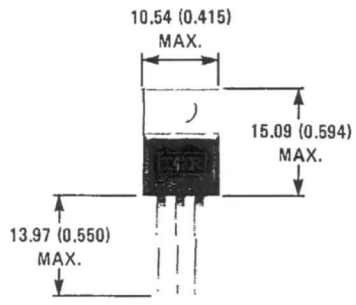
The HEXFET transistors also offer all of the well established advantages of MOSFETs such as voltage control, very fast switching, ease of paralleling, and temperature stability of the electrical parameters.

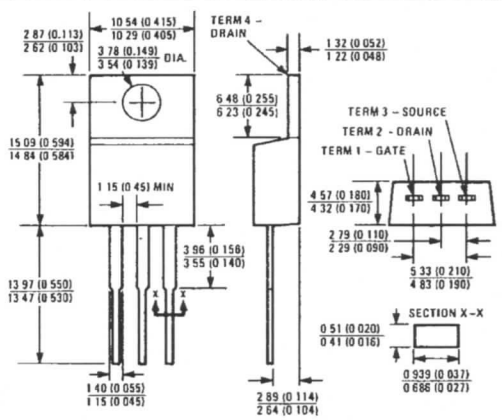
They are well suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers, high energy pulse circuits, and in systems that are operated from low voltage batteries, such as automotive, portable equipment, etc.

Features:

- Extremely Low $R_{DS(on)}$
- Compact Plastic Package
- Fast Switching
- Low Drive Current
- Ease of Paralleling
- Excellent Temperature Stability
- Parts Per Million Quality

CASE STYLE AND DIMENSIONS





Case Style TO-220AB
Dimensions in Millimeters and (Inches)

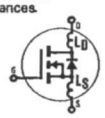
Absolute Maximum Ratings

	Parameter	IRFZ20	IRFZ22	Units
V_{DS}	Drain - Source Voltage ①	50	50	V
V_{DGR}	Drain - Gate Voltage (R_{GS} = 20 KΩ) ①	50	50	V
I_D @ T_C = 25°C	Continuous Drain Current	15	14	A
I_D @ T_C = 100°C	Continuous Drain Current	10	9.0	A
I_{DM}	Pulsed Drain Current ③	60	56	A
V_{GS}	Gate - Source Voltage	±20		V
P_D @ T_C = 25°C	Max. Power Dissipation	40 (See Fig. 14)		W
	Linear Derating Factor	0.32 (See Fig. 14)		W/K ④
I_{LM}	Inductive Current, Clamped	(See Fig. 15 and 16) L = 100μH		A
		60	56	
T_J T_{stg}	Operating Junction and Storage Temperature Range	−55 to 150		°C
	Lead Temperature	300 (0.063 in. (1.6mm) from case for 10s)		°C

Electrical Characteristics @ T_C = 25°C (Unless Otherwise Specified)

	Parameter	Type	Min.	Typ.	Max.	Units	Test Conditions
BV_{DSS}	Drain - Source Breakdown Voltage	IRFZ20	50	—	—	V	V_{GS} = 0V
		IRFZ22	50	—	—	V	I_D = 250 μA
$V_{GS(th)}$	Gate Threshold Voltage	ALL	2.0	—	4.0	V	V_{DS} = V_{GS}, I_D = 250 μA
I_{GSS}	Gate-Source Leakage Forward	ALL	—	—	500	nA	V_{GS} = 20V
I_{GSS}	Gate-Source Leakage Reverse	ALL	—	—	−500	nA	V_{GS} = −20V
I_{DSS}	Zero Gate Voltage Drain Current	ALL	—	—	250	μA	V_{DS} = Max. Rating, V_{GS} = 0V
			—	—	1000	μA	V_{DS} = Max. Rating × 0.8, V_{GS} = 0V, T_C = 125°C
$I_{D(on)}$	On-State Drain Current ②	IRFZ20	15	—	—	A	V_{DS} > $I_{D(on)}$ × $R_{DS(on)max.}$, V_{GS} = 10V
		IRFZ22	14	—	—	A	
$R_{DS(on)}$	Static Drain-Source On-State Resistance ②	IRFZ20	—	0.080	0.100	Ω	V_{GS} = 10V, I_D = 9.0A
		IRFZ22	—	0.110	0.120	Ω	
g_{fs}	Forward Transconductance ②	ALL	5.0	6.0	—	S (℧)	V_{DS} > $I_{D(on)}$ × $R_{DS(on)}$ max., I_D = 9.0A
C_{iss}	Input Capacitance	ALL	—	560	850	pF	V_{GS} = 0V, V_{DS} = 25V, f = 1.0 MHz
C_{oss}	Output Capacitance	ALL	—	250	350	pF	See Fig. 10
C_{rss}	Reverse Transfer Capacitance	ALL	—	60	100	pF	
$t_{d(on)}$	Turn-On Delay Time	ALL	—	15	30	ns	V_{DD} ≅ 25V, I_D = 9.0A, Z_o = 50Ω
t_r	Rise Time	ALL	—	45	90	ns	See Fig. 17
$t_{d(off)}$	Turn-Off Delay Time	ALL	—	20	40	ns	(MOSFET switching times are essentially independent of operating temperature.)
t_f	Fall Time	ALL	—	15	30	ns	
Q_g	Total Gate Charge (Gate-Source Plus Gate-Drain)	ALL	—	12	17	nC	V_{GS} = 10V, I_D = 20A, V_{DS} = 0.8 Max. Rating. See Fig. 18 for test circuit. (Gate charge is essentially independent of operating temperature.)
Q_{gs}	Gate-Source Charge	ALL	—	9.0	—	nC	
Q_{gd}	Gate-Drain ("Miller") Charge	ALL	—	3.0	—	nC	
L_D	Internal Drain Inductance	ALL	—	3.5	—	nH	Measured from the contact screw on tab to center of die.
			—	4.5	—	nH	Measured from the drain lead, 6mm (0.25 in.) from package to center of die.
L_S	Internal Source Inductance	ALL	—	7.5	—	nH	Measured from the source lead, 6mm (0.25 in.) from package to source bonding pad.

Modified MOSFET symbol showing the internal device inductances.



Thermal Resistance

R_{thJC}	Junction-to-Case	ALL	—	—	3.12	K/W ④	
R_{thCS}	Case-to-Sink	ALL	—	1.0	—	K/W ④	Mounting surface flat, smooth, and greased.
R_{thJA}	Junction-to-Ambient	ALL	—	—	80	K/W ④	Typical socket mount

Source-Drain Diode Ratings and Characteristics

I_S	Continuous Source Current (Body Diode)	IRFZ20	—	—	15	A	Modified MOSFET symbol showing the integral reverse P-N junction rectifier.
		IRFZ22	—	—	14	A	
I_{SM}	Pulse Source Current (Body Diode) ③	IRFZ20	—	—	60	A	
		IRFZ22	—	—	56	A	
V_{SD}	Diode Forward Voltage ②	IRFZ20	—	—	1.6	V	T_C = 25°C, I_S = 15A, V_{GS} = 0V
		IRFZ22	—	—	1.4	V	T_C = 25°C, I_S = 14A, V_{GS} = 0V
t_{rr}	Reverse Recovery Time	ALL	—	100	—	ns	T_J = 150°C, I_F = 15A, dI_F/dt = 100A/μs
Q_{RR}	Reverse Recovered Charge	ALL	—	0.4	—	μC	T_J = 150°C, I_F = 15A, dI_F/dt = 100A/μs
t_{on}	Forward Turn-on Time	ALL	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by L_S + L_D.